



**THE DATASHEET OF
IKW30N65ES5XKSA1**



TRENCHSTOP™ 5 high speed soft switching IGBT co-packed with full current rated RAPID 1 fast and soft antiparallel diode

Features

- $V_{CE} = 650\text{ V}$
- $I_C = 30\text{ A}$
- High speed smooth switching device for hard & soft switching
- Very low V_{CEsat} , 1.35 V at nominal current
- Plug and play replacement of previous generation IGBTs
- 650 V breakdown voltage
- Low gate charge Q_G
- IGBT co-packed with full rated current RAPID 1 fast antiparallel diode
- Maximum junction temperature $T_{vjmax} = 175^\circ\text{C}$
- Qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models: <http://www.infineon.com/igbt/>

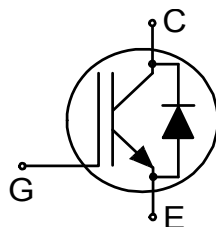
Potential applications

- Resonant converters
- Uninterruptible power supplies
- Welding converters
- Mid to high range switching frequency converters

Description

Package pin definition:

- Pin G - gate
- Pin C & backside - collector
- Pin E - emitter



| Type | Package | Marking |
|-------------|------------|---------|
| IKW30N65ES5 | PG-TO247-3 | K30EES5 |

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1 Package

Table 1 Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit |
|---|---------------|--|--------|------|------|------|
| | | | Min. | Typ. | Max. | |
| Internal emitter inductance measured 5 mm (0.197 in.) from case | L_E | | | 13 | | nH |
| Storage temperature | T_{stg} | | -55 | | 150 | °C |
| Soldering temperature | T_{sold} | wave soldering 1.6 mm (0.063 in.) from case for 10 s | | | 260 | °C |
| Mounting torque | M | M3 screw, Maximum of mounting processes: 3 | | | 0.6 | Nm |
| Thermal resistance, junction-ambient | $R_{th(j-a)}$ | | | | 40 | K/W |
| IGBT thermal resistance, junction-case | $R_{th(j-c)}$ | | | | 0.8 | K/W |
| Diode thermal resistance, junction-case | $R_{th(j-c)}$ | | | | 1 | K/W |

2 IGBT

Table 2 Maximum rated values

| Parameter | Symbol | Note or test condition | Values | Unit |
|--|--------------|---|----------|------|
| Collector-emitter voltage | V_{CE} | $T_{vj} \geq 25\text{ °C}$ | 650 | V |
| DC collector current, limited by T_{vjmax} | I_C | $T_c = 25\text{ °C}$ | 62 | A |
| | | $T_c = 100\text{ °C}$ | 39.5 | |
| Pulsed collector current, t_p limited by T_{vjmax} | I_{Cpulse} | | 120 | A |
| Turn-off safe operating area | | $V_{CE} \leq 650\text{ V}$, $t_p = 1\text{ }\mu\text{s}$, $T_{vj} \leq 175\text{ °C}$ | 120 | A |
| Gate-emitter voltage | V_{GE} | | ± 20 | V |
| Transient gate-emitter voltage | V_{GE} | $t_p \leq 10\text{ }\mu\text{s}$, $D < 0.01$ | ± 30 | V |
| Power dissipation | P_{tot} | $T_c = 25\text{ °C}$ | 188 | W |
| | | $T_c = 100\text{ °C}$ | 94 | |

Table 3 Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit |
|--------------------------------------|-------------|--|--|------|------|---------------|
| | | | Min. | Typ. | Max. | |
| Collector-emitter breakdown voltage | V_{BRCES} | $I_C = 0.2 \text{ mA}, V_{GE} = 0 \text{ V}$ | 650 | | | V |
| Collector-emitter saturation voltage | V_{CESat} | $I_C = 30 \text{ A}, V_{GE} = 15 \text{ V}$ | $T_{vj} = 25 \text{ °C}$ | 1.35 | 1.7 | V |
| | | | $T_{vj} = 125 \text{ °C}$ | 1.5 | | |
| | | | $T_{vj} = 175 \text{ °C}$ | 1.6 | | |
| Gate-emitter threshold voltage | V_{GETh} | $I_C = 0.3 \text{ mA}, V_{CE} = V_{GE}$ | 3.2 | 4 | 4.8 | V |
| Zero gate-voltage collector current | I_{CES} | $V_{CE} = 650 \text{ V}, V_{GE} = 0 \text{ V}$ | $T_{vj} = 25 \text{ °C}$ | | 50 | μA |
| | | | $T_{vj} = 175 \text{ °C}$ | | 1400 | |
| Gate-emitter leakage current | I_{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$ | | | 100 | nA |
| Transconductance | g_{fs} | $I_C = 30 \text{ A}, V_{CE} = 20 \text{ V}$ | | 42 | | S |
| Input capacitance | C_{ies} | $V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 1000 \text{ kHz}$ | | 1800 | | pF |
| Output capacitance | C_{oes} | $V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 1000 \text{ kHz}$ | | 55 | | pF |
| Reverse transfer capacitance | C_{res} | $V_{CE} = 25 \text{ V}, V_{GE} = 0 \text{ V}, f = 1000 \text{ kHz}$ | | 7 | | pF |
| Gate charge | Q_G | $I_C = 30 \text{ A}, V_{GE} = 15 \text{ V}, V_{CC} = 520 \text{ V}$ | | 70 | | nC |
| Turn-on delay time | $t_{d(on)}$ | $V_{CC} = 400 \text{ V}, V_{GE} = 0/15 \text{ V},$ $R_{G(on)} = 13 \text{ }\Omega,$ $R_{G(off)} = 13 \text{ }\Omega$ | $T_{vj} = 25 \text{ °C},$ $I_C = 30 \text{ A}$ | | 17 | ns |
| | | | $T_{vj} = 25 \text{ °C},$ $I_C = 15 \text{ A}$ | | 16 | |
| | | | $T_{vj} = 150 \text{ °C},$ $I_C = 30 \text{ A}$ | | 17 | |
| | | | $T_{vj} = 150 \text{ °C},$ $I_C = 15 \text{ A}$ | | 16 | |
| Rise time (inductive load) | t_r | $V_{CC} = 400 \text{ V}, V_{GE} = 0/15 \text{ V},$ $R_{G(on)} = 13 \text{ }\Omega,$ $R_{G(off)} = 13 \text{ }\Omega$ | $T_{vj} = 25 \text{ °C},$ $I_C = 30 \text{ A}$ | | 12 | ns |
| | | | $T_{vj} = 25 \text{ °C},$ $I_C = 15 \text{ A}$ | | 6 | |
| | | | $T_{vj} = 150 \text{ °C},$ $I_C = 30 \text{ A}$ | | 13 | |
| | | | $T_{vj} = 150 \text{ °C},$ $I_C = 15 \text{ A}$ | | 7 | |

(table continues...)

Table 3 (continued) Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit | |
|----------------------------|--------------|--|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| Turn-off delay time | $t_{d(off)}$ | $V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 13\ \Omega,$ $R_{G(off)} = 13\ \Omega$ | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 124 | | ns |
| | | | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 133 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 149 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 179 | | |
| Fall time (inductive load) | t_f | $V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 13\ \Omega,$ $R_{G(off)} = 13\ \Omega$ | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 30 | | ns |
| | | | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 33 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 55 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 54 | | |
| Turn-on energy | E_{on} | $V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 13\ \Omega,$ $R_{G(off)} = 13\ \Omega$ | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 0.56 | | mJ |
| | | | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 0.26 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 0.77 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 0.41 | | |
| Turn-off energy | E_{off} | $V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 13\ \Omega,$ $R_{G(off)} = 13\ \Omega$ | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 0.32 | | mJ |
| | | | $T_{vj} = 25\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 0.17 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 30\text{ A}$ | | 0.56 | | |
| | | | $T_{vj} = 150\text{ }^\circ\text{C},$ $I_C = 15\text{ A}$ | | 0.31 | | |

(table continues...)

Table 3 (continued) Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit | |
|--------------------------------|----------|--|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| Total switching energy | E_{ts} | $V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V},$ $R_{G(on)} = 13\ \Omega,$ $R_{G(off)} = 13\ \Omega$ | $T_{vj} = 25\text{ °C},$ $I_C = 30\text{ A}$ | | 0.88 | | mJ |
| | | | $T_{vj} = 25\text{ °C},$ $I_C = 15\text{ A}$ | | 0.43 | | |
| | | | $T_{vj} = 150\text{ °C},$ $I_C = 30\text{ A}$ | | 1.33 | | |
| | | | $T_{vj} = 150\text{ °C},$ $I_C = 15\text{ A}$ | | 0.72 | | |
| Operating junction temperature | T_{vj} | | -40 | | 175 | °C | |

3 Diode

Table 4 Maximum rated values

| Parameter | Symbol | Note or test condition | Values | Unit | |
|--|--------------|----------------------------|-----------------------|------|---|
| Repetitive peak reverse voltage | V_{RRM} | $T_{vj} \geq 25\text{ °C}$ | 650 | V | |
| Diode forward current, limited by T_{vjmax} | I_F | limited by bondwire | $T_C = 25\text{ °C}$ | 40 | A |
| | | | $T_C = 100\text{ °C}$ | 39.5 | |
| Diode pulsed current, t_p limited by T_{vjmax} | I_{Fpulse} | | 120 | A | |

Table 5 Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit | |
|-----------------------|--------|------------------------|--------------------------|------|------|------|---|
| | | | Min. | Typ. | Max. | | |
| Diode forward voltage | V_F | $I_F = 30\text{ A}$ | $T_{vj} = 25\text{ °C}$ | | 1.45 | 1.7 | V |
| | | | $T_{vj} = 125\text{ °C}$ | | 1.42 | | |
| | | | $T_{vj} = 175\text{ °C}$ | | 1.39 | | |

(table continues...)

Table 5 (continued) Characteristic values

| Parameter | Symbol | Note or test condition | Values | | | Unit | |
|-------------------------------------|-----------|------------------------|---|------|------|------|---------------|
| | | | Min. | Typ. | Max. | | |
| Diode reverse recovery time | t_{rr} | $V_R = 400\text{ V}$ | $T_{vj} = 25\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 75 | | ns |
| | | | $T_{vj} = 25\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 52 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 110 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 78 | | |
| Diode reverse recovery charge | Q_{rr} | $V_R = 400\text{ V}$ | $T_{vj} = 25\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 0.83 | | μC |
| | | | $T_{vj} = 25\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 0.6 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 1.75 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 1.25 | | |
| Diode peak reverse recovery current | I_{rrm} | $V_R = 400\text{ V}$ | $T_{vj} = 25\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 18 | | A |
| | | | $T_{vj} = 25\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 18.5 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 30\text{ A}$, $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 26.5 | | |
| | | | $T_{vj} = 150\text{ °C}$, $I_F = 15\text{ A}$, $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 26.2 | | |

(table continues...)

Table 5 (continued) Characteristic values

| Parameter | Symbol | Note or test condition | | Values | | | Unit |
|---|--------------|------------------------|---|--------|------|------|------------------|
| | | | | Min. | Typ. | Max. | |
| Diode peak rate of fall of reverse recovery current | di_{rr}/dt | $V_R = 400\text{ V}$ | $T_{vj} = 25\text{ °C},$ $I_F = 30\text{ A},$ $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 900 | | A/ μs |
| | | | $T_{vj} = 25\text{ °C},$ $I_F = 15\text{ A},$ $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 1320 | | |
| | | | $T_{vj} = 150\text{ °C},$ $I_F = 30\text{ A},$ $-di_F/dt = 1200\text{ A}/\mu\text{s}$ | | 1000 | | |
| | | | $T_{vj} = 150\text{ °C},$ $I_F = 15\text{ A},$ $-di_F/dt = 1900\text{ A}/\mu\text{s}$ | | 1200 | | |
| Operating junction temperature | T_{vj} | | | -40 | | 175 | °C |

Note: For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

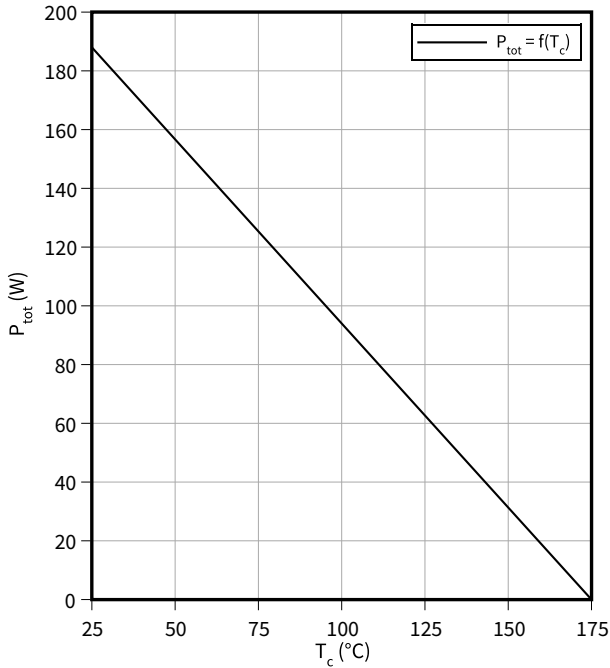
Electrical Characteristic at $T_{vj} = 25\text{ °C}$, unless otherwise specified.

Dynamic test circuit, parasitic inductance $L_\sigma = 30\text{ nH}$, parasitic capacitor $C_\sigma = 30\text{ pF}$ from Fig. E. Energy losses include “tail” and diode reverse recovery.

4 Characteristics diagrams

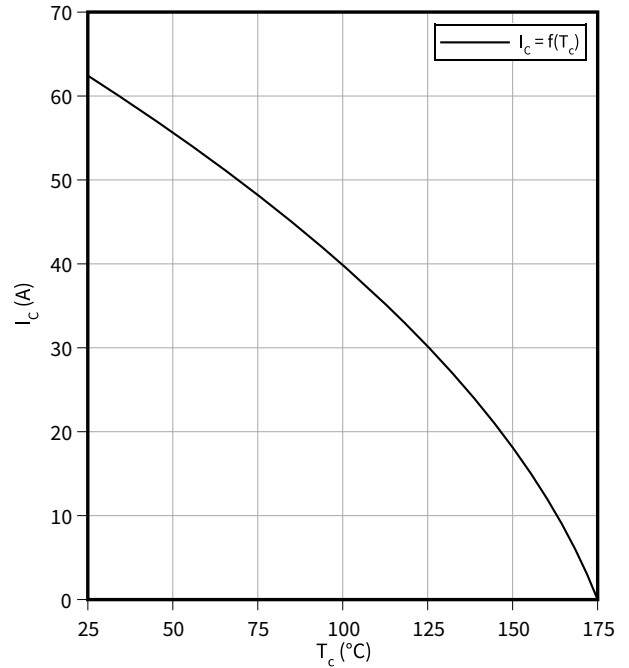
Power dissipation as a function of case temperature

$P_{tot} = f(T_c)$
 $T_{vj} \leq 175\text{ °C}$



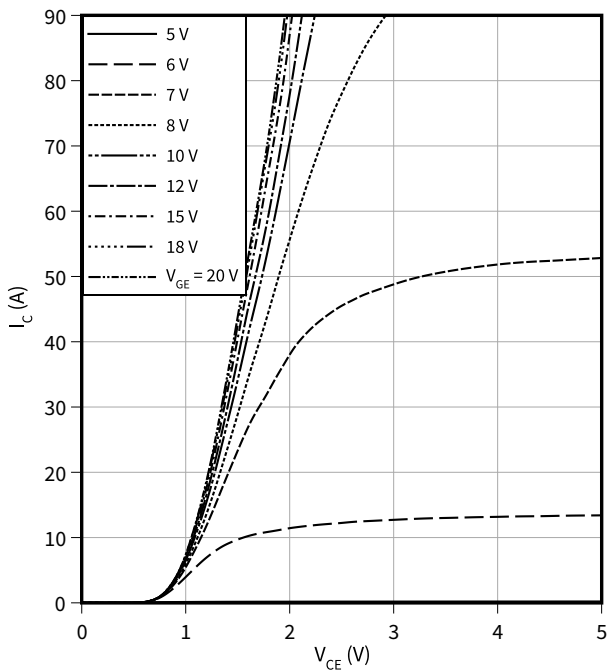
Collector current as a function of case temperature

$I_C = f(T_c)$
 $T_{vj} \leq 175\text{ °C}, V_{GE} \geq 15\text{ V}$



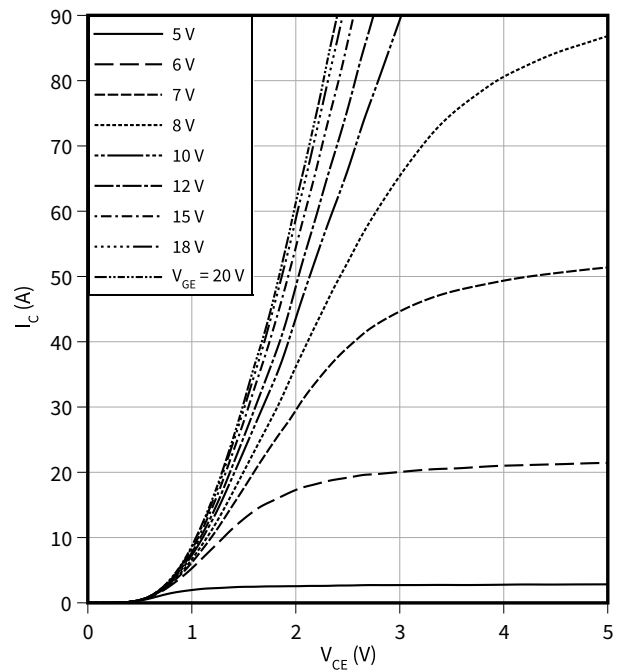
Typical output characteristic

$I_C = f(V_{CE})$
 $T_{vj} = 25\text{ °C}$



Typical output characteristic

$I_C = f(V_{CE})$
 $T_{vj} = 150\text{ °C}$

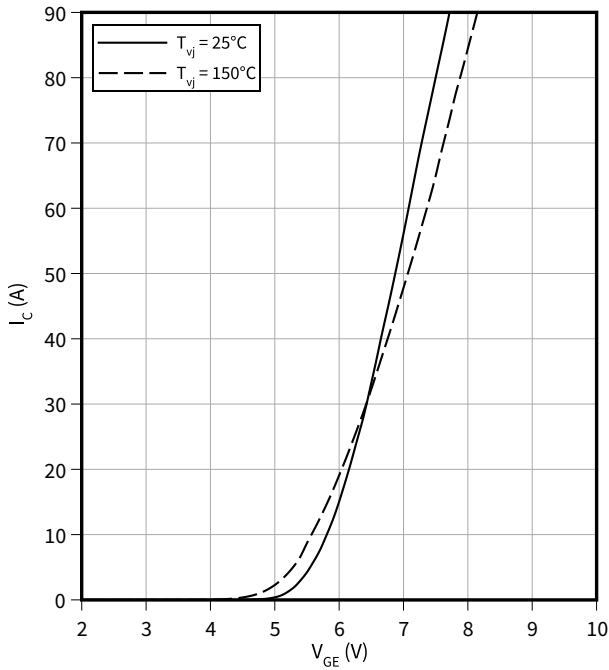


4 Characteristics diagrams

Typical transfer characteristic

$I_C = f(V_{GE})$

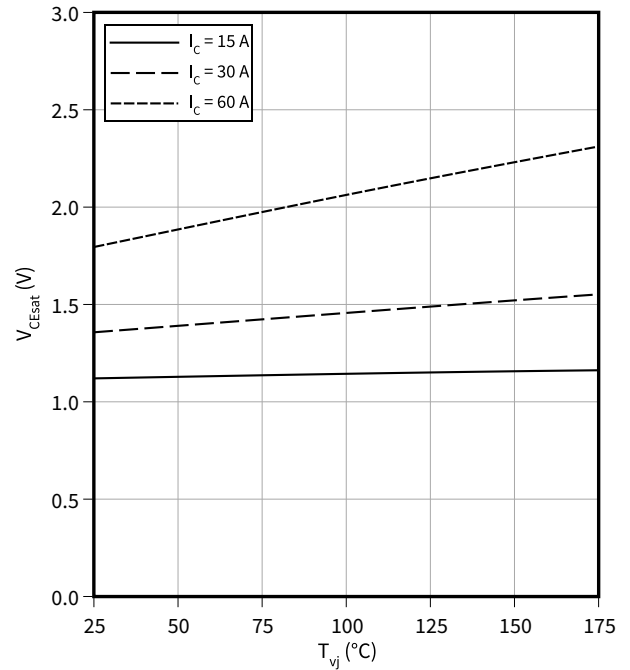
$V_{CE} = 20\text{ V}$



Typical collector-emitter saturation voltage as a function of junction temperature

$V_{CEsat} = f(T_{vj})$

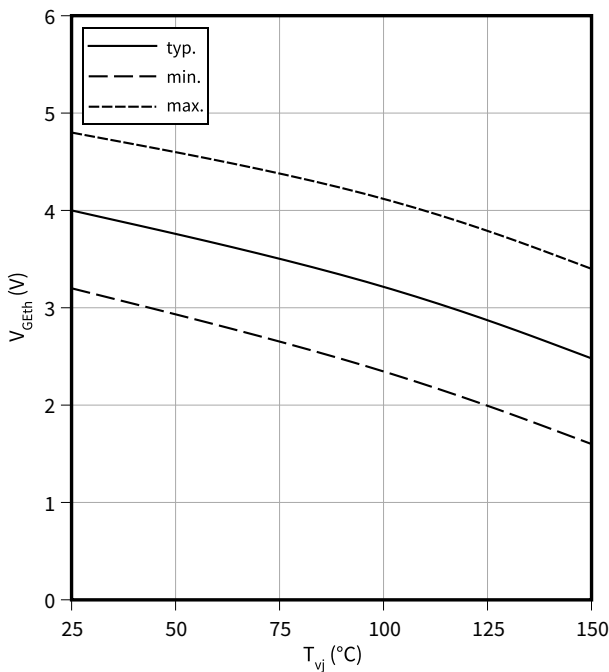
$V_{GE} = 15\text{ V}$



Gate-emitter threshold voltage as a function of junction temperature

$V_{GEth} = f(T_{vj})$

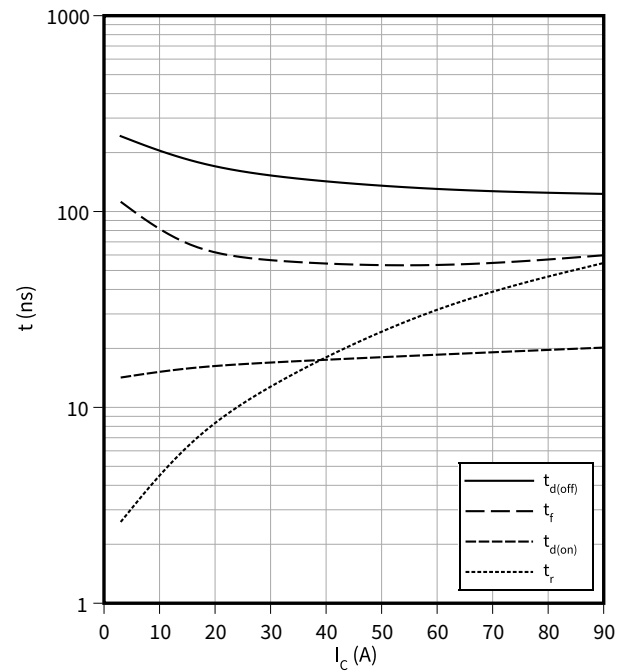
$I_C = 0.3\text{ mA}$



Typical switching times as a function of collector current

$t = f(I_C)$

$V_{CC} = 400\text{ V}, T_{vj} = 150^\circ\text{C}, V_{GE} = 0/15\text{ V}, R_G = 13\ \Omega$

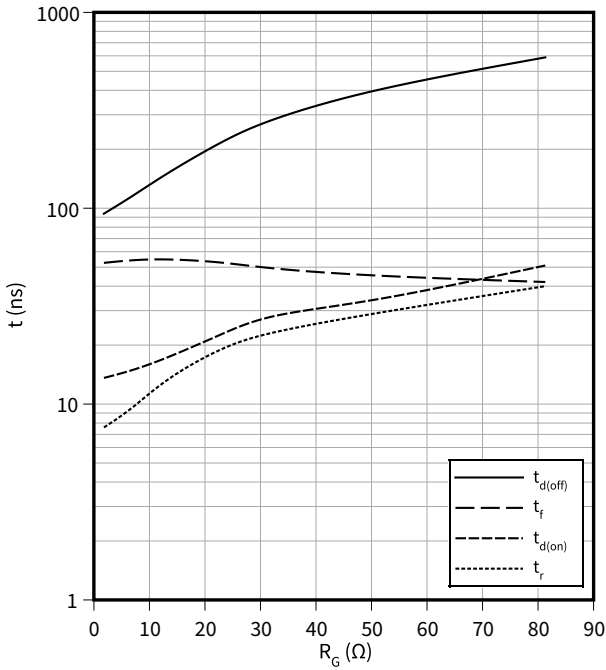


4 Characteristics diagrams

Typical switching times as a function of gate resistor

$t = f(R_G)$

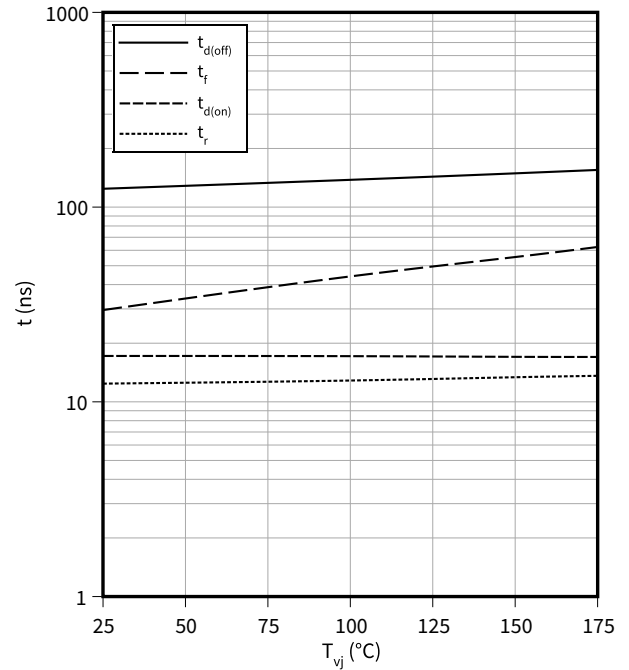
$I_C = 30\text{ A}, V_{CC} = 400\text{ V}, T_{vj} = 150\text{ °C}, V_{GE} = 0/15\text{ V}$



Typical switching times as a function of junction temperature

$t = f(T_{vj})$

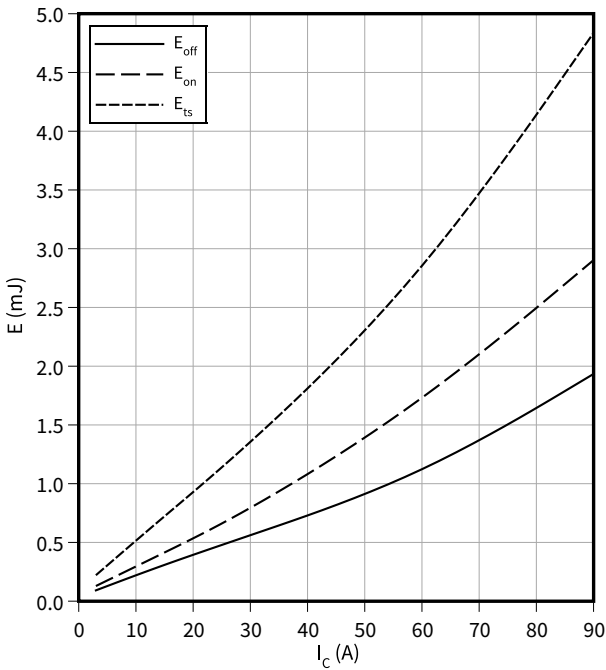
$I_C = 30\text{ A}, V_{CC} = 400\text{ V}, V_{GE} = 0/15\text{ V}, R_G = 13\text{ }\Omega$



Typical switching energy losses as a function of collector current

$E = f(I_C)$

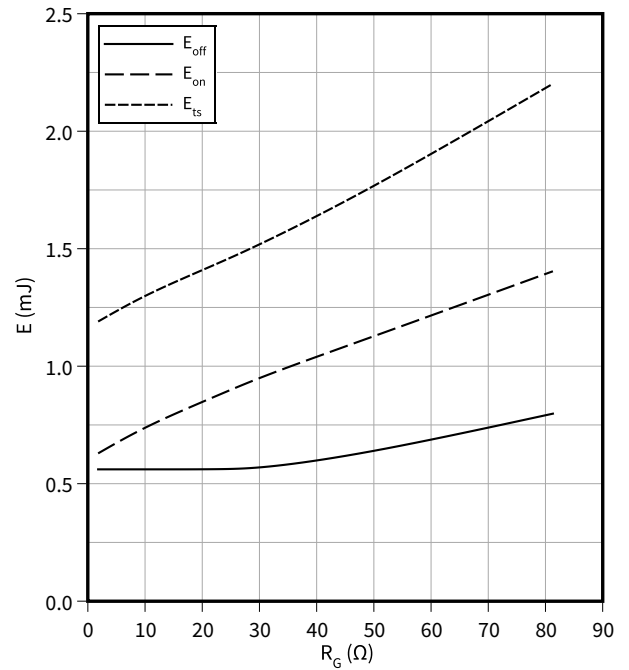
$V_{CC} = 400\text{ V}, T_{vj} = 150\text{ °C}, V_{GE} = 0/15\text{ V}, R_G = 13\text{ }\Omega$



Typical switching energy losses as a function of gate resistor

$E = f(R_G)$

$I_C = 30\text{ A}, V_{CC} = 400\text{ V}, T_{vj} = 150\text{ °C}, V_{GE} = 0/15\text{ V}$

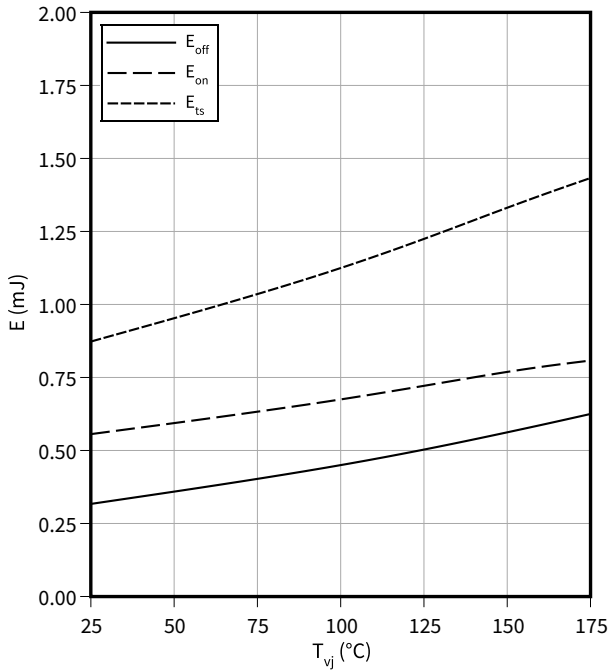


4 Characteristics diagrams

Typical switching energy losses as a function of junction temperature

$E = f(T_{vj})$

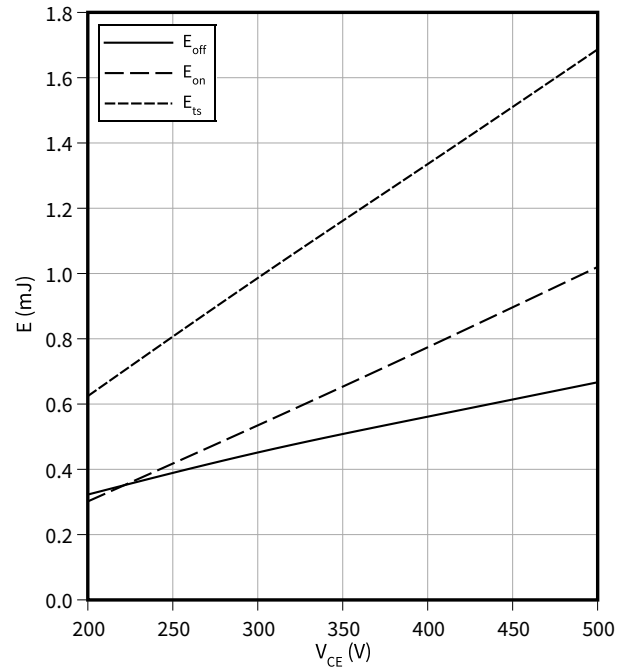
$I_C = 30\text{ A}$, $V_{CC} = 400\text{ V}$, $V_{GE} = 0/15\text{ V}$, $R_G = 13\ \Omega$



Typical switching energy losses as a function of collector emitter voltage

$E = f(V_{CE})$

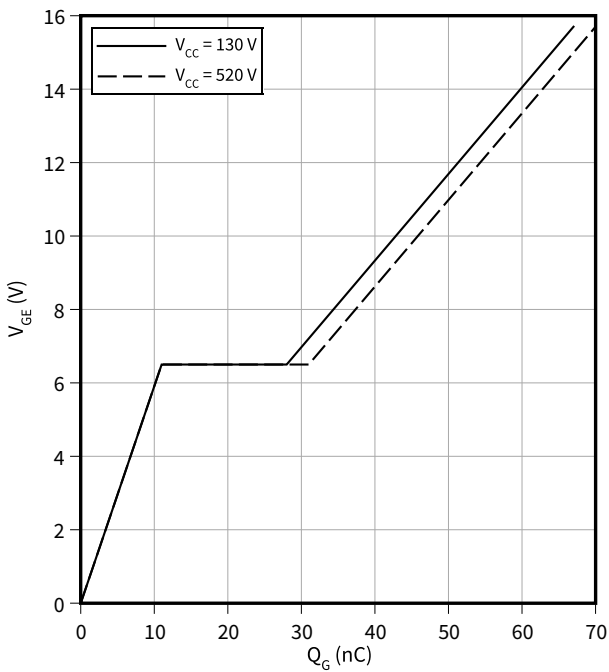
$I_C = 30\text{ A}$, $T_{vj} = 150\text{ °C}$, $V_{GE} = 0/15\text{ V}$, $R_G = 13\ \Omega$



Typical gate charge

$V_{GE} = f(Q_G)$

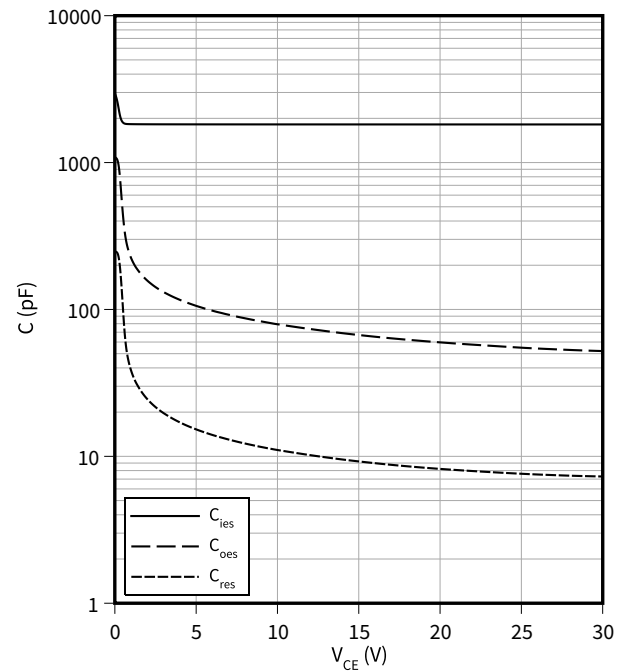
$I_C = 30\text{ A}$



Typical capacitance as a function of collector-emitter voltage

$C = f(V_{CE})$

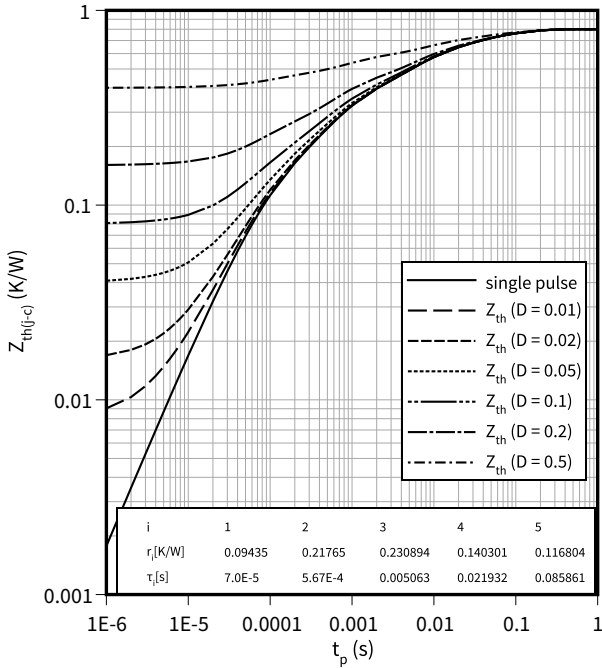
$f = 1000\text{ kHz}$, $V_{GE} = 0\text{ V}$



4 Characteristics diagrams

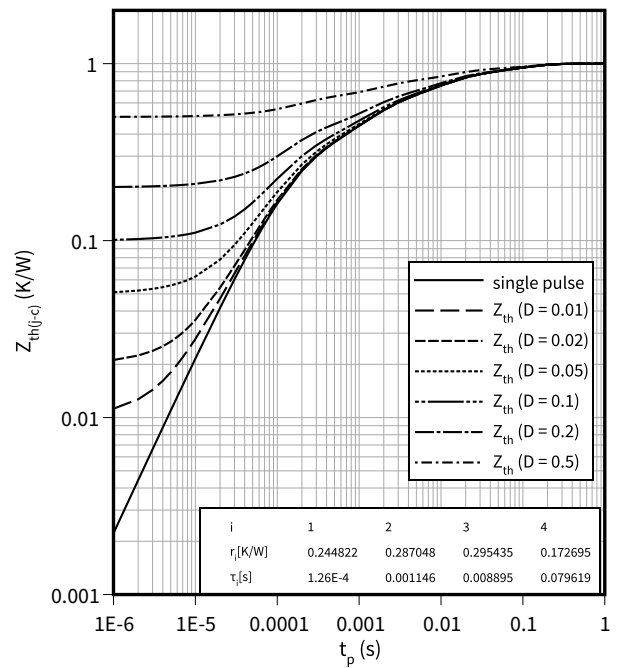
IGBT transient thermal impedance as a function of pulse width

$Z_{th(j-c)} = f(t_p)$
 $D = t_p/T$



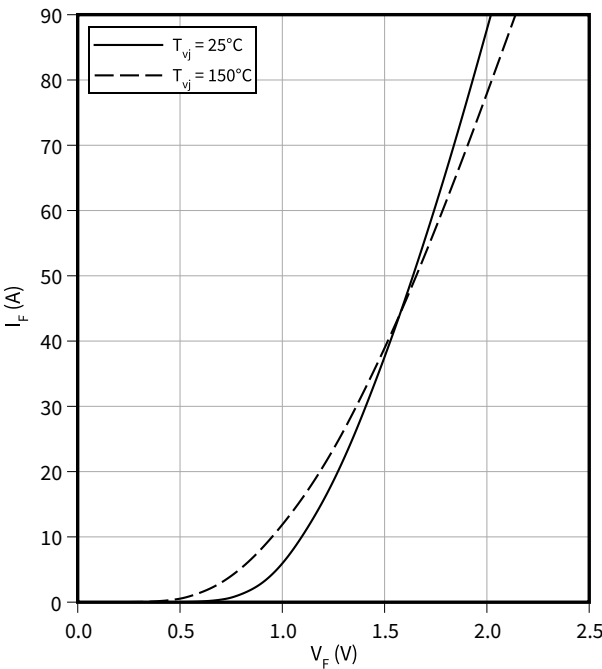
Diode transient thermal impedance as a function of pulse width

$Z_{th(j-c)} = f(t_p)$
 $D = t_p/T$



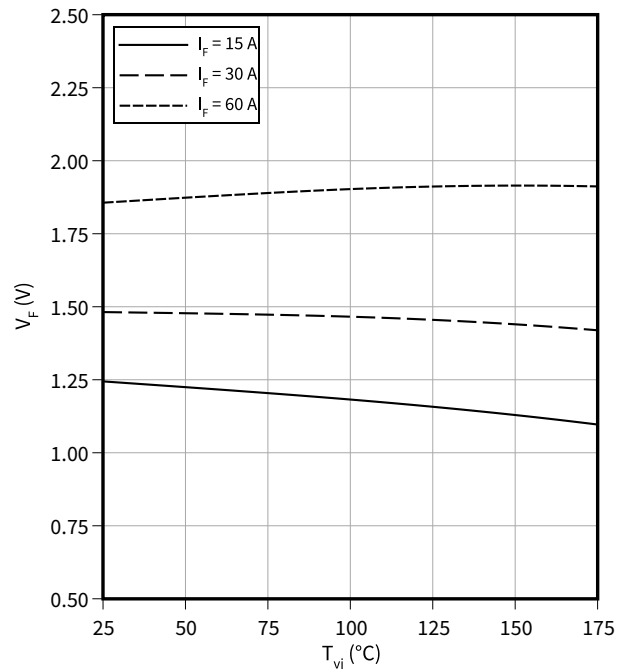
Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$



Typical diode forward voltage as a function of junction temperature

$V_F = f(T_{vj})$

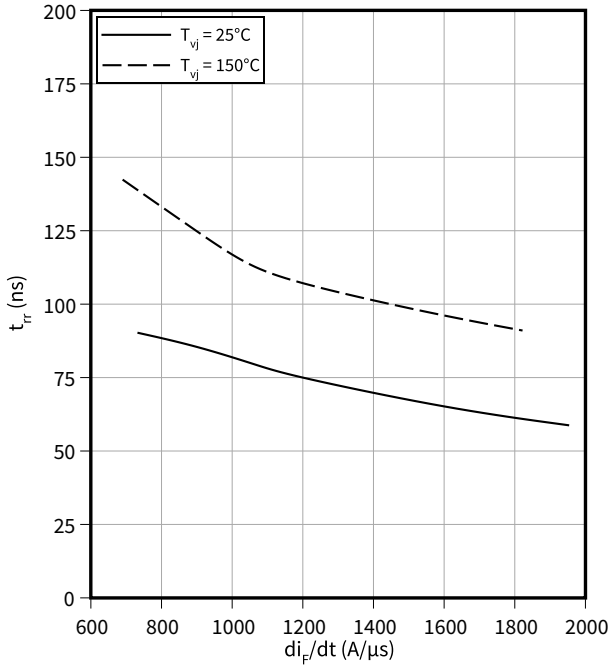


4 Characteristics diagrams

Typical reverse recovery time as a function of diode current slope

$t_{rr} = f(di_F/dt)$

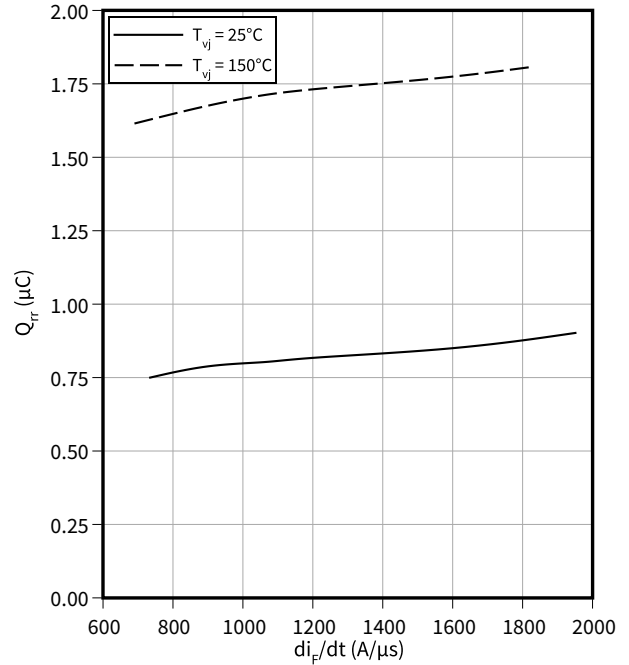
$V_R = 400\text{ V}, I_F = 30\text{ A}$



Typical reverse recovery charge as a function of diode current slope

$Q_{rr} = f(di_F/dt)$

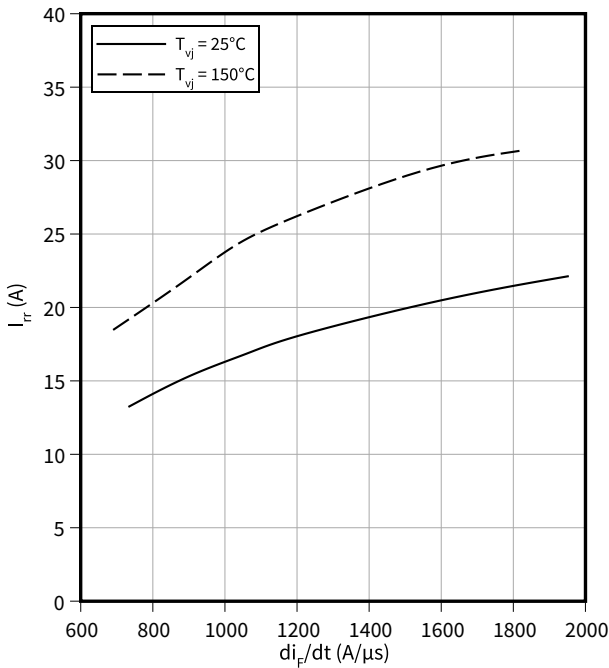
$V_R = 400\text{ V}, I_F = 30\text{ A}$



Typical reverse recovery current as a function of diode current slope

$I_{rrm} = f(di_F/dt)$

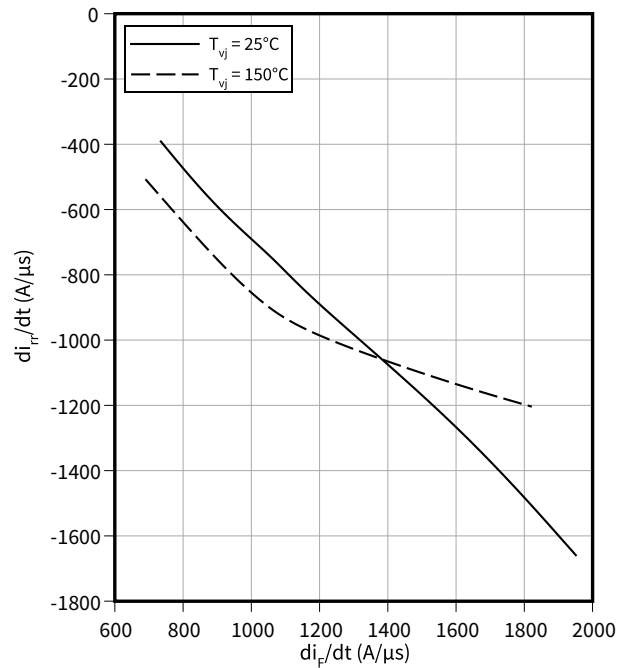
$V_R = 400\text{ V}, I_F = 30\text{ A}$



Typical diode peak rate of fall of reverse recovery current as a function of diode current slope

$di_{rr}/dt = f(di_F/dt)$

$V_R = 400\text{ V}, I_F = 30\text{ A}$



5 Package outlines

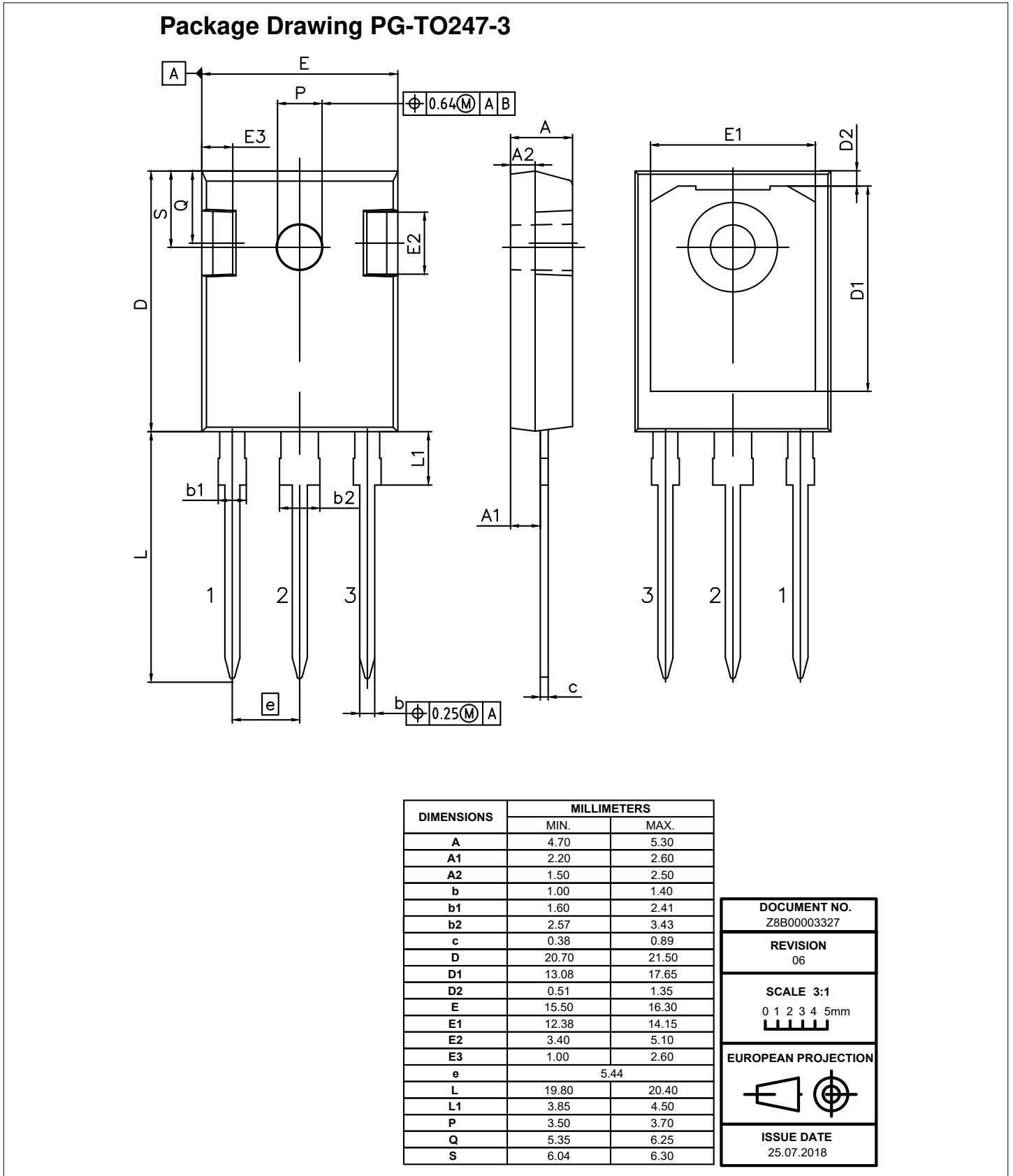


Figure 1

6 Testing conditions

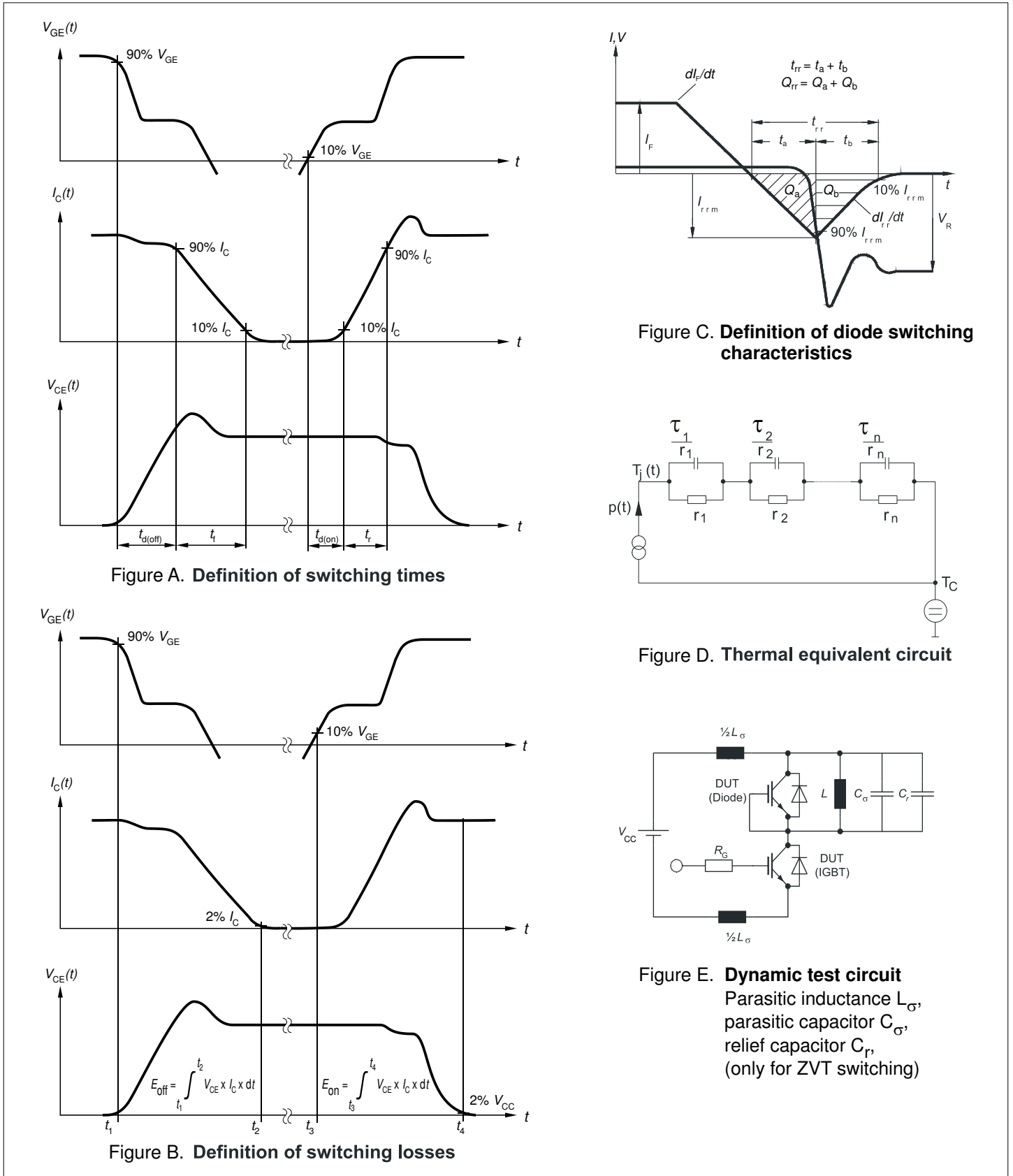


Figure 2

Revision history

| Document revision | Date of release | Description of changes |
|-------------------|-----------------|---|
| V1.1 | 2015-08-12 | Preliminary data sheet |
| V2.1 | 2015-09-22 | Final data sheet |
| V2.2 | 2015-10-16 | Minor change $I_c(V_{CE})$ Fig. 3 and Fig. 4 |
| n/a | 2020-11-30 | Datasheet migrated to a new system with a new layout and new revision number schema: target or preliminary datasheet = 0.xy; final datasheet = 1.xy |
| 1.10 | 2023-01-17 | Correction of diagram: "Typical switching energy losses as a function of collector emitter voltage" Editorial changes |

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